CLAIMS

What is claimed is:

5 1. An electronic component reliability determination method comprising:

executing an initialization process; implementing a field condition determination process;

performing a field condition reliability analysis process; and

10 performing a reliability information management process.

2. An electronic component reliability determination method of claim 1 further comprising sensing and tracking initial component startup time after shipping.

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3. An electronic component reliability determination method of claim 1 further comprising:

checking the integrity of non volatile memory;

initializing random access memory (RAM) with previously stored

20 values;

defining a reliability sampling period or interval; and starting background tasks.

- 4. An electronic component reliability determination method of claim 1 wherein said field condition determination process includes sensing operational parameter information.
- 5 5. An electronic component reliability determination method of claim 4 wherein said operational parameter information includes a temperature measurement associated with a component.
- 6. An electronic component reliability determination method of claim 1
 10 further comprising establishing an interface for presenting reliability information to a user.
 - 7. An electronic component reliability determination method of claim 1 further comprising determining a field condition adjustment factor value and instantaneous failure rate value.
 - 8. An electronic component reliability determination method of claim 7 wherein said instantaneous failure rate value is used to determine reliability of a component.

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9. An electronic component reliability determination method of claim 7 wherein said field condition reliability analysis process includes determination of reliability index values for components and a system.

CONFIDENTIAL 33 CSCO-7199

10. An electronic component reliability determination method of claim 1 further comprising saving parameter information and present value of a reliability indicator.

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- 11. An electronic component reliability determination method of claim 10 further comprising performing a reliability information condensing process.
- 12. An electronic component reliability determination method of claim 1110 wherein said reliability information condensing process comprises:

saving a reliability related reference value; receiving an updated reliability related value; determining a storage relationship value; and saving said storage relationship value.

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- 13. An electronic component reliability determination method of claim 1 wherein said field condition reliability analysis process includes determining a present value of a reliability indicator for a system.
- 20 14. An electronic component reliability determination system comprising: a sensor for sensing operational parameter information;
 - a bus for communicating information including said operational parameter information;

CONFIDENTIAL 34 CSCO-7199

- a reliability processing component for performing instructions including instructions for ascertaining a field condition adjusted reliability value; and
- a memory for saving said operational parameter information and said

 field condition adjusted reliability value.
 - 15. An electronic component reliability determination system of Claim 14 wherein said sensor includes a diode inside a component and said diode is utilized to establish a temperature measurement indication.

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- 16. An electronic component reliability determination system of Claim 14 wherein said sensor includes an ambient temperature measuring device.
- 17. An electronic component reliability determination system of Claim 14
 15 wherein said sensor includes air intake and air exhaust temperature measuring components.
 - 18. An electronic component reliability determination system of Claim 14 wherein said reliability processing component uses a temperature measurement detected by said sensor to calculate the temperature stress and a reliability adjustment factor.
 - 19. An electronic component reliability determination system of Claim 14

CONFIDENTIAL 35 CSCO-7199

wherein said reliability processing component performs instructions for calculating an instantaneous failure rate.

- 20. An electronic component reliability determination system of Claim 14 wherein said reliability processing component performs instructions to determine an adjusted instantaneous reliability value.
- 21. An electronic component reliability determination system of Claim 14 wherein information is stored in said memory component in a reliability information condensing process format.
- 22. A computer readable medium with instructions embedded therein for causing a processor to implement a reliability determination process including:
- an initialization module for directing implementation of an initialization process;

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- a reliability determination background module for directing a field condition determination process and a field condition reliability analysis process; and
- a reliability determination runtime module for interfacing with an operating system.

CONFIDENTIAL 36 CSCO-7199

23. A computer readable medium of claim 22 wherein said initialization module includes instructions for:

checking the integrity of non volatile memory;

initializing random access memory (RAM) with previously stored

5 values;

defining a reliability sampling period or interval; and starting background tasks.

- 24. A computer readable medium of claim 22 wherein said background
 10 module includes instructions for implementing reliability associated
 firmware activities.
 - 25. A computer readable medium of claim 22 wherein said background module divides background tasks into multiple background threads that operate separately.
 - 26. A computer readable medium of claim 22 wherein said runtime module performs reliability determination activities including calculation of instantaneous failure rates and cumulative reliability index values.

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27. A communication device comprising:means for controlling information communication;

CONFIDENTIAL 37 CSCO-7199

means for determining component reliability adjusted in accordance with field condition impacts; and

means for organizing information associated with said component reliability.

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- 28. A communication device of claim 27 further comprising a means for ascertaining field condition information.
- 29. A communication device of claim 27 wherein said field condition10 information includes a temperature measurement.
 - 30. A communication device of claim 27 wherein said means for determining component reliability adjusted in accordance with field condition impacts determines an instantaneous failure rate and a cumulative reliability indication.

CONFIDENTIAL 38 CSCO-7199